

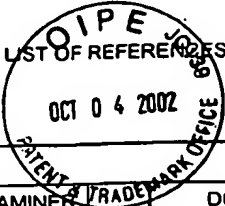


SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217612US2SDIV		SERIAL NO. 10/058,091	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideo ANDO, et al.			
				FILING DATE January 29, 2002		GROUP 2615	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
SH	AO	11-238318	08/31/1999	JAPAN			X
SH	AP	8-315551	11/29/1996	JAPAN			X
SH	AQ	9-135412	05/20/1997	JAPAN			X
SH	AR	10-112166	04/28/1998	JAPAN			X
SH	AS	11-162119	06/18/1999	JAPAN			X
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Syed Hasan/				Date Considered 12/26/2006			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217612US2S DIV		SERIAL NO. 10/058,091	
				APPLICANT Hideo ANDO, et al.			
				FILING DATE January 29, 2002		GROUP 2615	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SH	AA	5,778,142	7Jul98	TAIRA, et al.			
SH	AB	5,915,067	22Jun99	NONOMURA, et al.			
SH	AC	5,999,696	7Dec99	TSUGA, et al.			
SH	AD	5,999,698	7Dec99	NAKAI, et al.			
SH	AE	6,088,507	11Jul00	YAMAUCHI, et al.			
SH	AF	6,094,414	25Jul00	TAIRA, et al.			
SH	AG	6,112,011	29Aug00	HISATOMI			
SH	AH	6,198,874 B1	6Mar01	KANESHIGE, et al.			
SH	AI	6,222,806	24Apr01	MORI, et al.			
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
SH	AO	JP 8-263969	11Oct96	JAPAN	x		
SH	AP	JP 60-236163	22Nov85	JAPAN (English Abstract of Japanese Patent)		x	
SH	AQ	JP 58-088978	27May83	JAPAN (English Abstract of Japanese Patent)		x	
SH	AR	JP 02-206820	16Aug90	JAPAN (English Abstract of Japanese Patent)		x	
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
SH	AW	Explanation of Circumstances concerning Accelerated Examination for Japanese Patent Application No. 1998-133832 (with English translation)					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Syed Hasan/					Date Considered 12/26/2006		
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217612US-2S DIV		SERIAL NO. New Divisional Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hideo ANDO, et al.			
				FILING DATE HEREWITH		GROUP To be assigned	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
SH	AO	58-68978	5/27/83	Japan			X
SH	AP	60-236163	11/22/85	Japan			X
SH	AQ	2-206820	8/16/90	Japan			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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U.S. PTO

10/05/91

01/29/02

Attorney Docket No. 217612-2S DIV

Notice of References Cited

Application/Control No.

New Divisional App.

Examiner

To Be Assigned

Applicant(s)/Patent Under
Reexamination
ANDO ET AL

Art Unit

Unassigned

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SH	A	US-6,212,330-B1	04-2001	Yamamoto et al	388	95
SH	B	US-6,181,870-B1	01-2001	Okada et al	388	95
	C	US- -				
	D	US- -				
	E	US- -				
	F	US- -				
	G	US- -				
	H	US- -				
	I	US- -				
	J	US- -				
	K	US- -				
	L	US- -				
	M	US- -				

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★		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	- -					
	O	- -					
	P	- -					
	Q	- -					
	R	- -					
	S	- -					
	T	- -					

NON-PATENT DOCUMENTS

★		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	W						
	X						

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 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office
 FO-892 (Rev. 01-2001)

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Part of Paper No. 3

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Application/Control No.
New Divisional App.Applicant(s)/Patent Under
Reexamination
ANDO ET ALExaminer
To be AssignedArt Unit
Unassigned

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
SH	A	US-6,317,809 B1	11-2001	Kulakowski et al	711
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

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	X	

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